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| Application Number | 10/077,784 |
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| Filing Date | February 20, 2002 |
| First Named Inventor | T rry L. Gilton |
| Art Unit | 2818 |
| Braminer Name | Not Yet Assigned |
| Altorney Docket Number | M4065 0482/P482 |

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¹ Applicant's unique citation designation number (optional). . ² See attached Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³
Enter Office that lessed the document, by the two-letter code (NIPO Standard ST.3): ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. ⁴ Kind of document by the appropriate symbols as indicated on the document under WiPO Standard ST, 16 if possible. ⁵ Applicant is to place a check mark here if English language Translation is attached.

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| First Named Inventor | Terry L. Gilton |
| Group Art Unit | 2818 |
| Examiner Name | Not Yet Assigned |
| Attorney Docket Number | M4065.0482/P482 |

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| 4 | Filing Dete | F bruary 20, 2002 |
| | First Named Inventor | Terry L. Gilton |
| | Group Art Unit | 2818 4 |
| 3 | Examiner Name | Not Yet Assigned |
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Substitute for form 1448B/PTO

Complete If Known 10/077,784 **Application Number** Filing Date February 20, 2002 First Named Inventor T my L. Gilton

| 1 | | | - | Group Art Unit | 2818 * |
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| Substitute for form 14488/PTO | | Complete If Known | |
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| and the second s | Application Number | 10/077,784 | | |
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| STATEMENT BY APPLICANT | First Named Inventor | Terry L. Gilton | | |
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| | Examiner Name | Not Yet Assigned | | |
| Sheet 6 | Attorney Docket Number | M4065.0482/P482 | | |

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| heet 7 of 8 | Attorney Docket Number | M4065.0482/P482 | | |

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| Filing Date | February 20, 2002 | | | |
| First Named Inventor | Terry L. Gilton | | | |
| Group Art Unit | 2818 | | | |
| Examiner Name | Not Yet Assigned | | | |
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